Search Notes				

•	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/621,447	KWON ET AL.
	Examiner	Art Unit
	Leila Malek	2611

SEARCHED			
Class	Subclass	Date	Examiner
375	130	10/13/2006	L.M
375	140	10/13/2006	L.M
375	147	10/13/2006	L.M
375	150	10/13/2006	L.M
375	152	10/13/2006	L.M
375	316	10/13/2006	L.M
375	340	10/13/2006	L.M
375	343	10/13/2006	L.M
			·

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
		-		

SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
EAST	10/13/2006	L.M
IEEE	10/13/2006	L.M
GOOGLE	10/13/2006	L.M
Consulted K. Burd	10/13/2006	L.M
,		
		·